



Synthesis and characterization of fluorinated polybenzoxazine material with low dielectric constant

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Abstract

It is well-known that low dielectric materials are used as insulating materials, and the incorporation of fluorinated substitutes into polymer is able to decrease its dielectric constant because of small dipole and the low polarizability of the C–F bond. In this study, a novel structure of the fluorinated benzoxazine (F-1 benzoxazine) has been synthesized by incorporating the trifluoromethyl groups into the monomer, and its structure has also been characterized by ^1H NMR, ^{19}F NMR and FT-IR. Further, we have prepared the fluorinated copolybenzoxazine (B-a/F-1 = 1/1) with substantially reduced dielectric constant at $K = 2.36$. In addition, this fluorinated copolybenzoxazine possesses high glass transition temperature and high thermal stability, which is suitable for high temperature operation for certain special processes of interlayer dielectrics.

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1. Introduction

Low dielectric constant materials ($K < 3.0$) have the advantage of facilitating manufacture of higher performance integrated-circuit (IC) devices with decreasing feature size of the chip [1]. However, interlevel dielectric materials must meet stringent material property requirements for successful integration into either the conventional or damascene interconnect structures. These requirements are based on electrical properties, thermal stability, thermomechanical, thermal stress properties, and moisture uptake. The desired electrical properties are low dielectric constant, low dielectric loss, and high breakdown voltage. However, the propagation delay and cross-talk are primary problems which have been concerned in dielectric materials.

Continuing improvement in device's performance has significantly affected its dimensional requirement. These enhancements have to reduce in the wiring pitch and increase in the number of wiring leave to fulfill demands for density and performance improvement, especially at high frequency operations in the hundreds of megahertz or even

gigahertz range. As device dimensions shrink to less than $0.18\ \mu\text{m}$ process (even $0.13\ \mu\text{m}$ or smaller), it is necessary to reduce either the resistance of the metallization or the dielectric constant of the IMD (inter-metal dielectrics) material or both [1,2]. The time, which is related to the resulting signal delay is given by Eq. (1).

$$\tau = RC \quad (1)$$

and call the RC the time delay of signals. R is the line resistance and C is the line capacitance of the used structure.

Reducing the resistance–capacitance (RC) [3,4] is needed in order to avoid propagation delay, cross-talk noise, and power dissipation [3]. Eq. (2) can be used to estimate the RC delay.

$$RC = 2\rho\varepsilon\varepsilon_0 \left(\frac{4L^2}{P^2} + \frac{L^2}{T^2} \right) \quad (2)$$

R : total line resistance, C : total line capacitance, ρ : metal resistivity, ε : dielectric constant, ε_0 : permittivity of free space, L : line length, P : the distance between two conducting lines, T : metal thickness.

After replacing the aluminum process by the copper process, the metal resistivity has been reduced from $2.650 \times 10^{-8}\ \Omega\text{m}$ to $1.678 \times 10^{-8}\ \Omega\text{m}$ [2]. The most

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feasible approach is to use an insulating material possessing a lower dielectric constant without changing the copper process. In addition to the low dielectric constant, materials must also exhibit high thermal stability (T_g and T_d), low thermal expansion coefficient, low moisture uptake, good chemical stability and electric properties for practical applications [1,3].

Polybenzoxazine (PBZZ) resins were found to possess several outstanding properties such as near-zero shrinkage after curing, high thermal stability and low water absorption [5]. Furthermore, the PBZZ has high glass transition temperature even though it has relatively low crosslinking density [6]. Several methods have been developed to lower the material dielectric constant [1–3]. Fluorinated polymer is a practicable and feasible approach to develop low dielectric materials. It is well-known that the incorporation of fluorinated substitutes into a polymer is able to decrease its dielectric constant because of small dipole and the low polarizability of the C–F bond [1,2,7]. Furthermore, polymer free volume is also increased by replacing methyl groups by trifluoromethyl groups [1].

In this paper, a series of fluorinated PBZZ possessing desirable properties of low dielectric constant with low RC delay time and high speed logic chip have been synthesized and characterized.

2. Experimental

2.1. Synthesis of 3-[4-(trifluoromethyl)phenol]-6-(2,2,2-trifluoro-1-(trifluoromethyl)-1-[3-[4-(trifluoromethyl)phenol]-3,4-dihydro-2H-1,3-benzoxazine-6-yl]-ethyl)-3,4-dihydro-2H-1,3-benzoxazine (F-1 benzoxazine)

The F-1 benzoxazine was prepared according to Scheme 1. 0.04 mol 37% formaldehyde aqueous solution and 5 ml dioxane were fed into a three-necked flask equipped with nitrogen flow and an ice bath for 10 min. Then, 0.02 mol 4-(trifluoromethyl)aniline dissolved in 5 ml dioxane was added into the reactor slowly by a dropping funnel. The mixture was stirred continuously for 10 min, and 0.01 mol hexafluorobisphenol A in 20 ml dioxane was added. The reaction temperature was raised to 100 °C, and the mixture was allowed to reflux for 24 h. The solvent was then removed by reducing pressure, and the yellow solid product obtained. The crude product was dissolved in ethyl ether and washed with 1N NaOH and water in sequence for three times. The product solution was dried by magnesium sodium and distilled by reducing pressure, a light yellow solid product, F-1 benzoxazine, in 71% yield was obtained.

2.2. Nuclear magnetic resonance (NMR)

^1H and ^{19}F NMR spectra were recorded on a Varian Unity Inova 500 FT NMR Spectrometer operating at

500 MHz with chemical shift reported in parts per million (ppm). Deuterium chloroform was used as solvent.

2.3. Fourier transform infrared spectroscopy (FT-IR)

FT-IR measurement was recorded on a Nicolet Avatar 320 FT-IR Spectrophotometer, 32 scans were collected with a spectral resolution of 1 cm^{-1} . Infrared spectra of the benzoxazine were obtained using the conventional NaCl method. The film used in this study was thin enough to obey the Beer–Lambert law. The sample chamber was purged with nitrogen during process of measurement in order to maintain sample film drying.

2.4. Reactants preparations

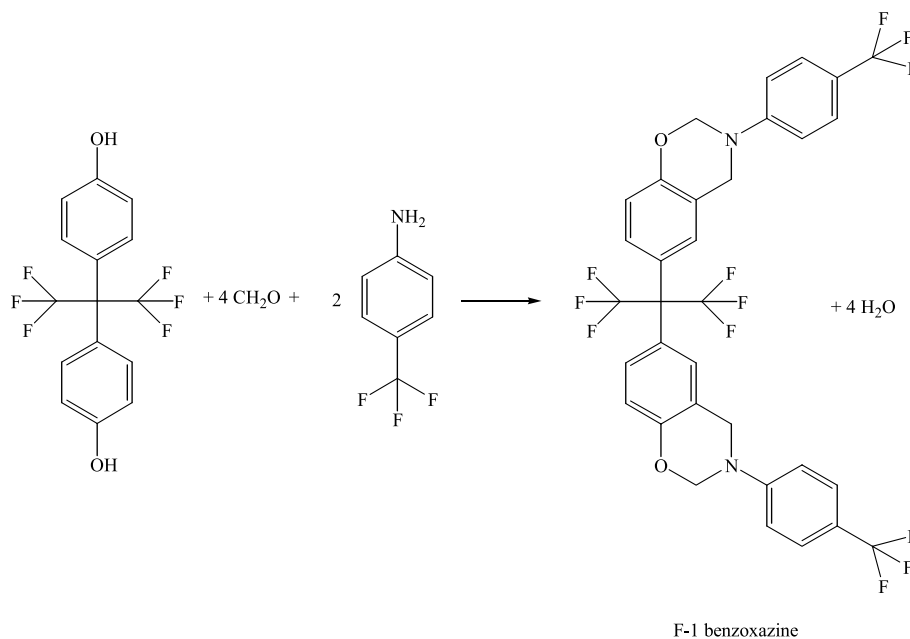
As shown in Scheme 2, blends of B-a/F-1 benzoxazines with different ratio were prepared by solution blending because the mechanical strength of the F-1 PBZZ is too weak to form a film for DEA experiment. The monomer mixture was stirred and dissolved in acetone and the solution was allowed to evaporate slowly at 50 °C for 1 day and cured at 180 °C for 4 h under vacuum to ensure total curing of the co-polybenzoxazine (PBZZ). After curing, a transparent, smooth, stiff and hazel to brown film was obtained.

2.5. Dielectric analysis

Dielectric relaxation data were obtained using a TA instrument (DEA-2970), which was incorporated a parallel plate cell arrangement and a computer-controlled furnace to ensure good electrical contact between the electrodes and the sample. In order to increase the accuracy of measuring dielectric constant, the flat films are required; therefore, we used the automatic scraper to form a flat film. The experiment was conducted under a nitrogen flow 20 ml/min and the thickness of sample was controlled between 0.125 and 0.75 mm. The dielectric constant and dielectric loss were determined with a heating rate of 1 °C/min from 25 to 50 °C with scan frequencies ranging from 1 to 10^5 Hz.

2.6. Differential scanning calorimetry (DSC)

The calorimetric measurement was performed using a TA Instruments Differential Scanning Calorimeter (DSC-2010) conducted under a nitrogen flow of 25 ml/min. The sample was preheated with a scan rate of 20 °C/min from 30 to 260 °C (or 300 °C) and maintained at 260 °C (or 300 °C) for 2 min. The measurement was made using 5–10 mg sample in a DSC sample cell by cooling to 30 °C quickly from the melt of the first scan. The second scan rate was 20 °C/min from 30 to 300 °C (or 350 °C) and the T_g was taken as the midpoint of the heat capacity transition between



Scheme 1. The synthesis of F-1 benzoxazine.

the upper and lower points of deviation from the extrapolated liquids and glass lines.

2.7. Thermogravimetric analysis (TGA)

Thermal stability of the cured sample was investigated by a Du Pont 2050 TGA. The cured sample of 5–10 mg was placed in a Pt cell and heated at a heating rate of 10 °C/min from 30 to 800 °C at a nitrogen flow of 90 ml/min.

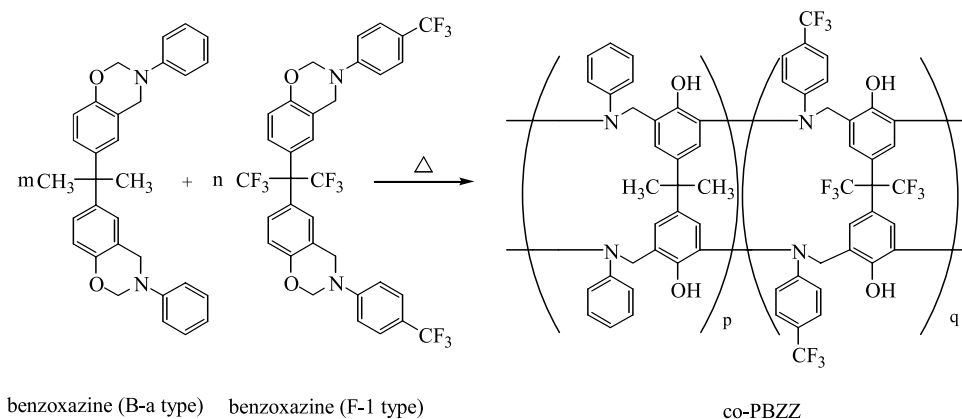
2.8. Water absorption

The cured sample was dried under vacuum at 80 °C for 12 h before placing in the environments of air or water for one day and one week. Then, the percentages of water absorption of cured sample were calculated.

3. Results and discussion

3.1. Nuclear magnetic resonance analysis

After the cyclization of oxazine, the characteristic peaks $\text{Ar}-\text{CH}_2-\text{N}$ and $\text{N}-\text{CH}_2-\text{O}$ can be observed in proton NMR [5,6]. Fig. 1 shows the ^1H NMR (CDCl_3 , 500 MHz) spectrum of F-1 benzoxazine: δ 4.65 ppm (4H, $\text{Ar}-\text{CH}_2-\text{N}$), δ 5.40 ppm (4H, $\text{N}-\text{CH}_2-\text{O}$), δ 6.78–7.52 ppm (14H, Ar). Fig. 2(a) and (b) show the ^{19}F NMR (CDCl_3 , 500 MHz) spectra of monomers of 4-(trifluoromethyl)aniline and hexafluorobisphenol A: δ -61.05 ppm (3F, $\text{NH}_2-\text{Ar}-\text{CF}_3$) [8], δ -63.25 ppm (6F, $\text{C}-\text{CF}_3$). The ^{19}F NMR (CDCl_3 , 500 MHz) spectrum of F-1 benzoxazine is shown in Fig. 3: δ -61.54 to -61.66 ppm (6F, $\text{N}-\text{Ar}-\text{CF}_3$), δ -63.81 to 63.94 ppm (6F, $\text{C}-\text{CF}_3$). The slight chemical shift (within 1 ppm) observed in ^{19}F NMR spectrum



Scheme 2. The ring opening process of B-a/ F-1 co-PBZZ.

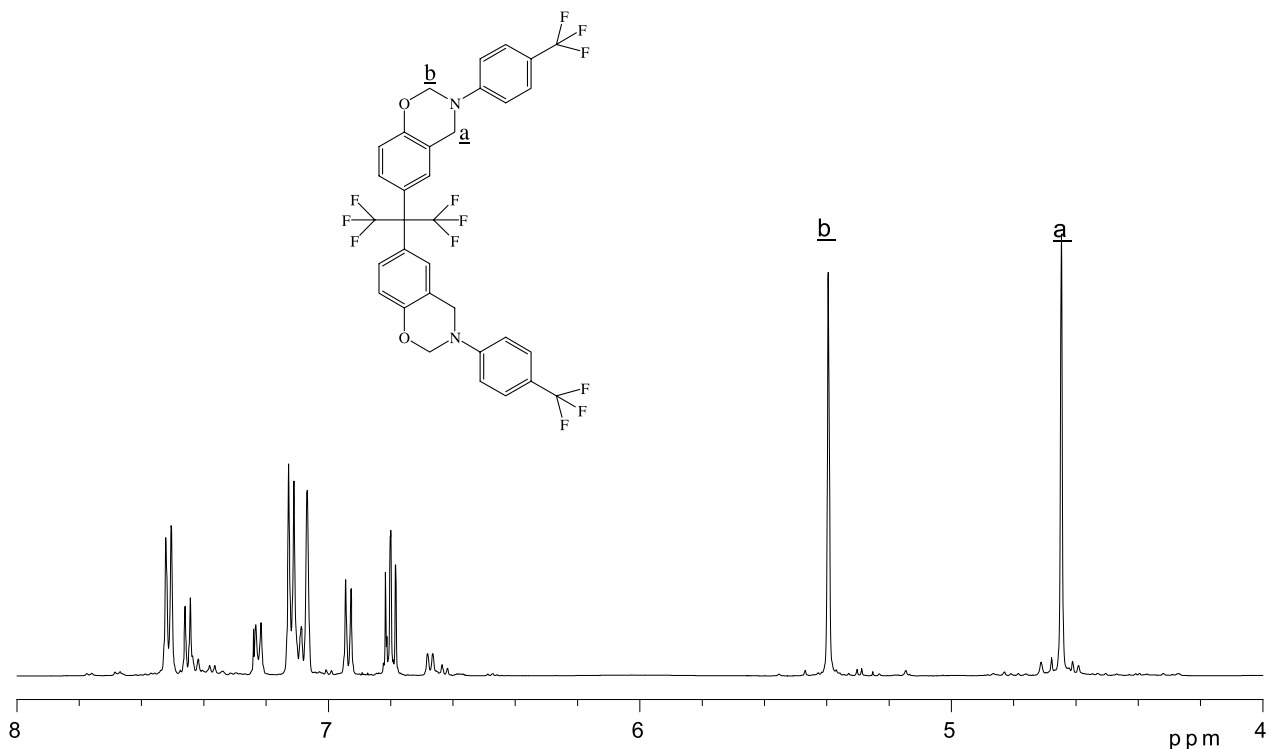


Fig. 1. The ^1H NMR spectrum of F-1 benzoxazine.

because the structure of the F-1 benzoxazine ring was formed.

3.2. Fourier transfer infrared spectroscopy analysis

The FT-IR spectrum of F-1 benzoxazine is shown in Fig. 4. The bands at 755 and 692 cm^{-1} (referred to

monosubstituted benzene) do not appear in comparing with the B-a type benzoxazine [9,10]. However, the same characteristic absorption bands of oxazine ring at 937 and 1521 cm^{-1} from the trisubstituted benzene ring, and at 1242 cm^{-1} from the CH_2 wagging appear. Besides, the absorptions at 1038 and 1228 cm^{-1} assigned to symmetric and asymmetric C–O–C bonds of the benzoxazine are both

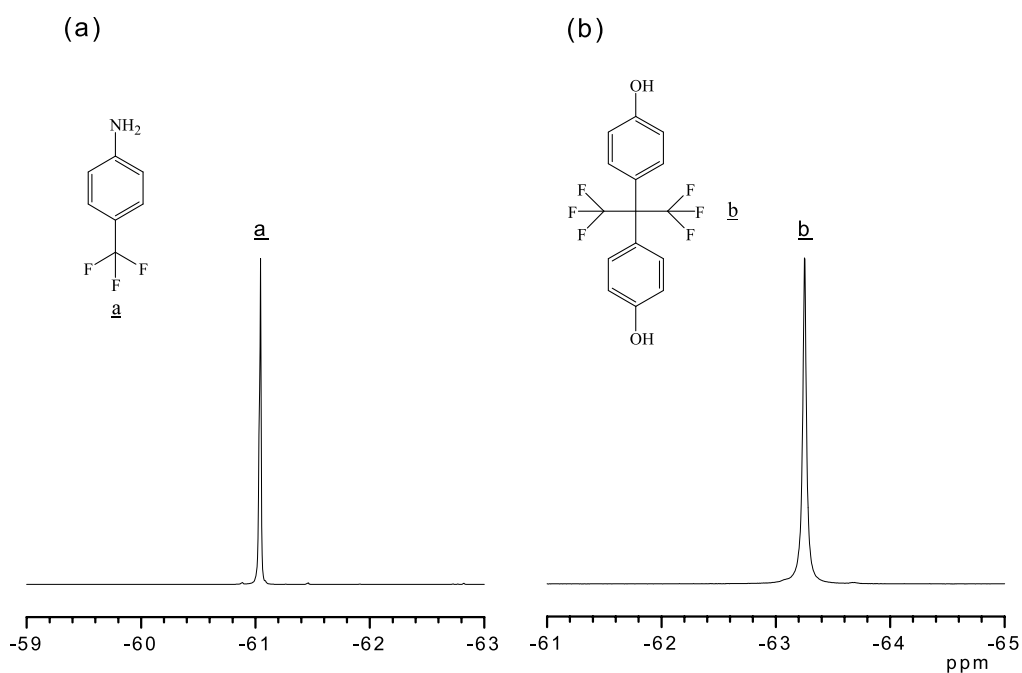
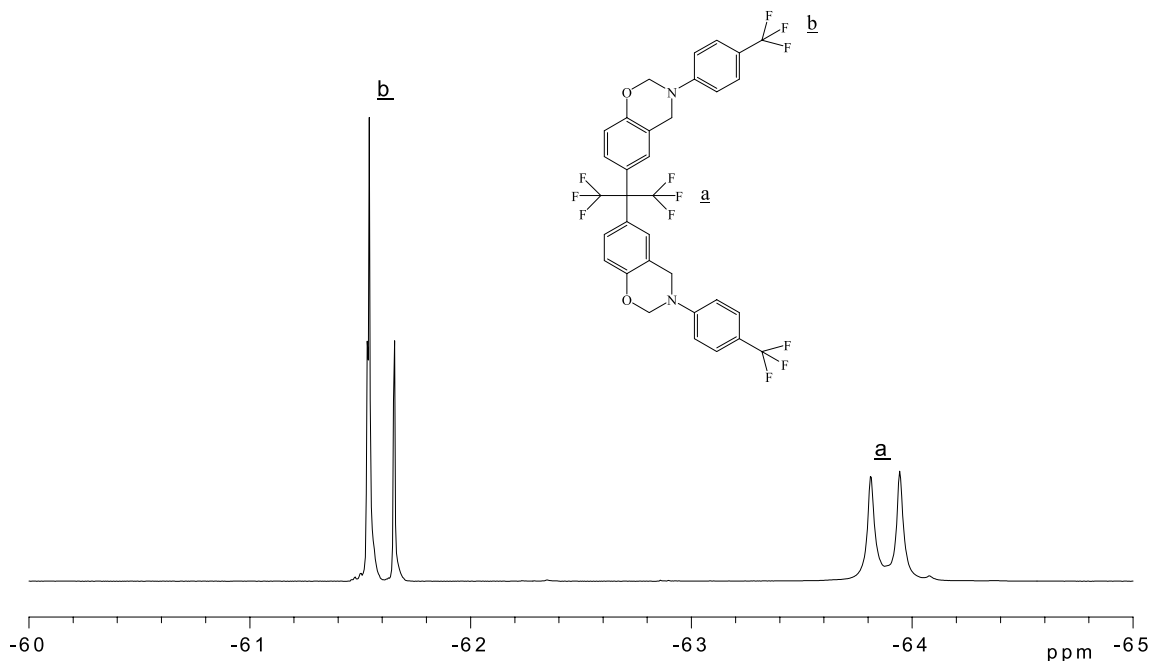


Fig. 2. The ^{19}F NMR spectra of (a) 4-(trifluoromethyl)aniline, (b) hexafluorobisphenol A.

Fig. 3. The ^{19}F NMR spectrum of F-1 benzoxazine.

present. Based on the NMR and FT-IR results, we confirmed that the F-1 benzoxazine was formed in the study.

3.3. Dielectric constant analysis

The dielectric constant K is directly related to the polarizability of a material, therefore, it is strongly dependent on its chemical structure [11]. Saturated hydrocarbons are significantly lower polarizable than species that are unsaturated, conjugated, or have polarizable phenyl

groups. This effect is demonstrated by comparing the dielectric constants of an aromatic PI with that of the semi-aliphatic PI [11]. In general, the K value can be lowered by breaking off the conjugated system or decreasing the number of phenyl group in the monomer. However, these alterations have to compromise with lower thermal stability. To fluorinate the polymer is one method to solve above-mentioned problems [12]. Fluorine substitution lowers the K value by decreasing the polarizability and the moisture absorption and by increasing the free volume. Substitution

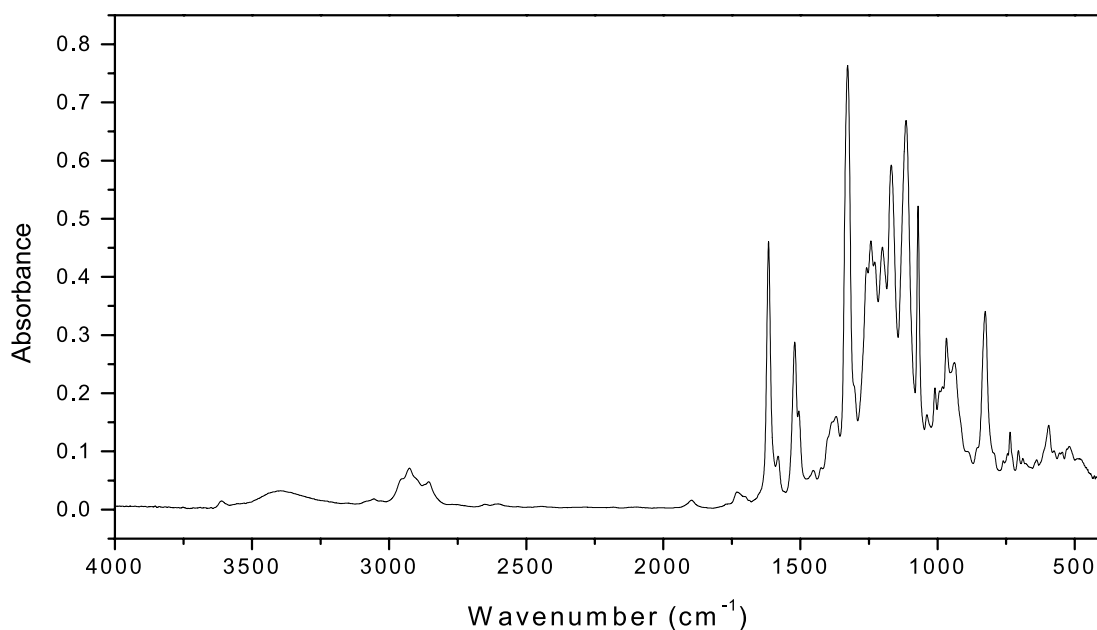


Fig. 4. The FT-IR spectrum of F-1 benzoxazine.

of hydrogen with F or $-\text{CF}_3$ group decreases the electronic polarizability due to strong electron-withdrawing inductive effect. The bulky $-\text{CF}_3$ group is able to reduce efficient molecular packing and increase the free volume. The hydrophobicity introduced by F substitution is important since the moisture, even in small concentrations, strongly affects the dielectric constant due to the large K value of water, 78.5 at 25 °C [2].

In this study, we incorporated fluorine atoms into the backbone of PBZZ. Table 1 presents the dielectric constant, and dissipation factor, $\tan\delta$, of co-PBZZ with different B-a/F-1 ratios measured at 10^5 Hz and 298 K. Prior to each measurement, the sample was thoroughly dried under vacuum to reduce the influence of the absorbed moisture on the dielectric constant. Comparing these co-PBZZ mixtures synthesized with different B-a/F-1 weight ratios, the incorporation of fluorinated substitution (F-1 benzoxazine) results in decreasing in the dielectric constant with minimum value of 2.36 (B-a/F-1 = 1/1). In addition, the dissipation factor is also a very important property of ILD (interlayer dielectrics) materials [13–15] that less than 0.005 at 1 MHz is normally required. In this study, those compositions all meet the requirement of dissipation factor. Hence, the fluorination of benzoxazine reduces its dielectric constant with tolerable dissipation factor.

3.4. Thermal properties

Thermal properties of organic polymers with low K dielectrics are another primary concern in process integration. The C–H, C–C, and C–N bonds of aliphatic polymers generally become unstable at temperatures above 400 °C [1–4] even in the nitrogen or vacuum environment. The resulting volatiles may cause delaminating or blistering in the ILD. Only organic materials composed of nonaliphatic C–H, C–C, C–N, and C–S bonds, such as aromatic, crosslinking or ladder structure, is able to resist such elevated temperatures. Unfortunately, material possessing good thermal stability generally tends to have high dielectric constant. The incorporation of fluorine atoms into the benzoxazine structure is able to achieve materials with high thermal stability and low dielectric constant. Fluorination can improve thermal properties partly because the C–F bond is stronger than the C–H bond [1]. More

Table 1
The dielectric constant and dissipation factor of B-a/F-1 co-PBZZ at 298 K and 10^5 Hz

B-a/F-1 (weight ratio)	Dielectric constant	Dissipation factor ($\tan\delta$)
1/0	3.56 ± 0.01	0.00206
1/0.05	3.02 ± 0.03	0.00235
1/0.1	2.85 ± 0.02	0.00282
1/0.2	2.76 ± 0.02	0.00287
1/0.5	2.39 ± 0.01	0.00387
1/1	2.36 ± 0.01	0.00440

important, it can reduce the dielectric constant due to its lower polarizability structure.

3.4.1. Glass transition temperature analysis

The glass transition temperature is an important property of a dielectric film. Exceeding T_g the polymer may cause a large decrease in Young's modulus and typically results in a shift in the dielectric properties. Hence, a polymer with T_g greater or equal to the highest processing temperature is desirable. All B-a/F-1 co-PBZZ were subjected to DSC measurements for the purpose of examining microscopic miscibility. Fig. 5 shows the DSC thermograms of all B-a/F-1 co-PBZZ exhibiting only one T_g from all composition. A single T_g strongly implies that all these B-a/F-1 co-PBZZs are homogenous. Fig. 6 shows the dependence of the T_g on the composition of these copolymers, increasing the F-1 benzoxazine content results in substantial T_g increase than average values. The hydrogen bonding interactions of O–H···F–C [16] and O–H···O–H are expected in these copolymers. Kwei equation [17] describes the effect of hydrogen bonding interaction on T_g between polymers or a copolymer as shown in Eq. (3):

$$T_g = \frac{W_1 T_{g1} + kW_2 T_{g2}}{(W_1 + kW_2)} + qW_1 W_2 \quad (3)$$

where W_1 and W_2 are weight fractions of the components, T_{g1} and T_{g2} represent the component glass transition

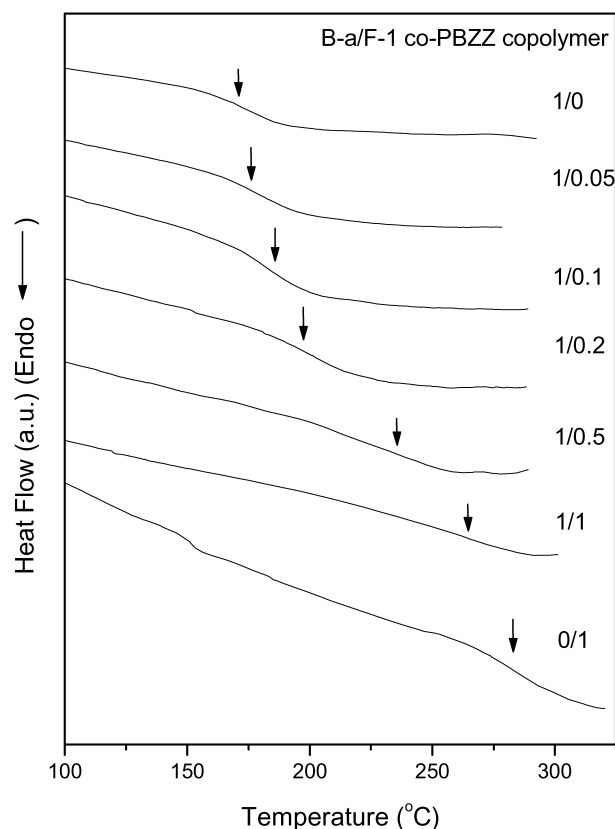


Fig. 5. The DSC scans of B-a/F-1 co-PBZZ copolymers with different composition.

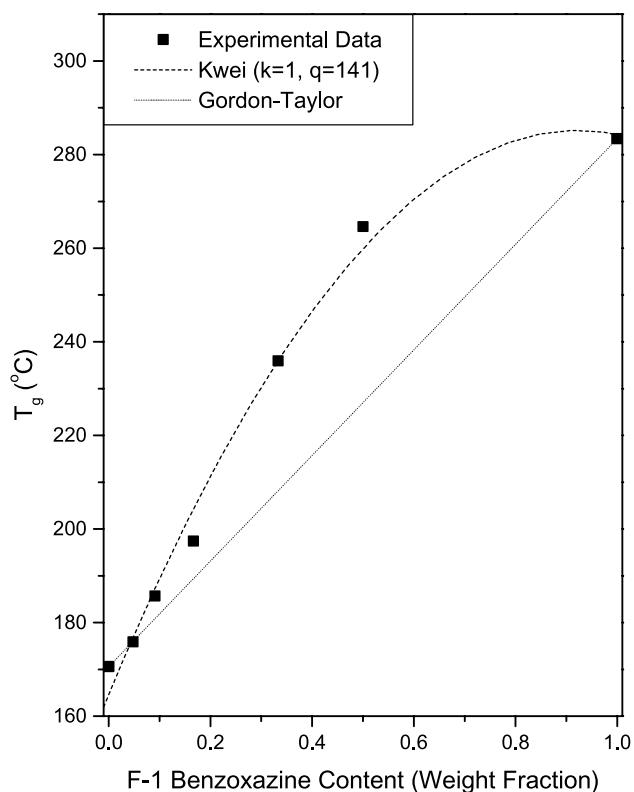


Fig. 6. T_g versus composition curved base on B-a/F-1 co-PBZZ copolymers.

temperatures. Both k and q are fitting constants. In general, the parameter q may be considered as a measurement of the specific interaction in a polymer blend system. When the intermolecular interaction is stronger than intramolecular interaction in a binary blend or copolymer, the value of q will be positive; otherwise, q will be negative. When the q value is larger, it represents that the interaction is stronger than the self-interaction of the blend. In case of no interaction existed between components, the q value will be equal to zero and its T_g behavior can be described by the Gordon–Taylor equation [18] as shown in Eq. (4).

$$T_g = \frac{W_1 T_{g1} + kW_2 T_{g2}}{(W_1 + kW_2)} \quad (4)$$

As shown in Fig. 5, the B-a/F-1 co-PBZZs are completely miscible in the amorphous phase and results in positive T_g deviation. After the ‘best fitting’ by the Kwei equation, $k = 1$ and $q = 141$ were obtained. In this study, a large positive q value of 141 indicates that a strong intermolecular interaction exists between B-a/F-1 co-PBZZ. This result can also explain why T_g s of these copolymers are positively deviated as shown in Fig. 6. The glass transition temperature increases about 113 °C, from 170.6 °C of the B-a benzoxazine to 283.4 °C (F-1 benzoxazine). The resulted higher T_g makes the high temperature applications possible.

3.4.2. Thermogravimetric analysis

For organic films, thermal stability is one of the most important requirements for new IMD materials. Unlike aluminum metallization, copper metallization can be achieved by electroplating or electroless plating (chemical reduction) besides PVD and CVD techniques [19–21]. These processes can be conducted at temperatures below 250 °C. Unfortunately, an annealing step is necessary to ensure void free copper deposits. Since this step is performed at temperatures in the range 400–450 °C for up to 1 h, any low K material must be able to withstand this temperature for several hours.

Table 2 shows the weight loss of different compositions of co-PBZZ. The incorporation of fluorinated structure into the backbone of B-a benzoxazine results in noticeable change in thermal stability. The minimum weight loss occurs in the pure F-1 PBZZ structure that can resist high temperature (above 400 °C).

3.5. Water absorption

Since the water possesses large dielectric constant value (78.5 at 25 °C) [2], the water absorption is required to be below 1%. Therefore, the hydrophobic character is required in the low dielectric constant materials. The PBZZ possesses low water absorption ability [5] due to its highly crosslink density and hydrophobic property, and their percentages of water absorption are listed in Table 3. The water absorptions are all below 1 wt%, even under the water environment. The results indicate that the fluorinated co-PBZZs possess an outstanding property of resisting moisture uptake.

4. Conclusions

In this study, we have synthesized a series of co-PBZZ with different B-a/F-1 ratios. A single glass transition temperature (T_g) over entire compositions indicates that the amorphous phase of the co-PBZZ is totally miscible and homogeneous. In addition, a large positive deviation based on Kwei equation in the T_g versus composition diagram, implies that strong hydrogen bonding interactions exist

Table 2
The weight loss of B-a/F-1 co-PBZZ under N₂ environment

B-a/F-1 (weight ratio)	5% (weight loss) temp. (°C)	10% (weight loss) temp. (°C)
1/0	329.0	363.6
1/0.05	329.9	366.1
1/0.1	346.1	379.7
1/0.2	354.7	400.2
1/0.5	360.5	420.6
1/1	368.6	430.6
0/1	374.4	455.7

Table 3
The percentages of water absorption of B-a/F-1 co-PBZZ at room temperature

Environment	B-a/F-1 co-PBZZ water absorption (%)						
	1/0	1/0.05	1/0.1	1/0.2	1/0.5	1/1	0/1
In air 1 day	<0.01	<0.01	<0.01	<0.01	<0.01	<0.01	<0.01
In air 1 week	<0.01	<0.01	<0.01	<0.01	<0.01	<0.01	<0.01
In water 1 day	0.24	<0.01	<0.01	<0.01	<0.01	<0.01	<0.01
In water 1 week	0.70	0.69	0.61	0.64	0.60	0.71	0.52

within B-a/F-1 co-PBZZ. Furthermore, the fluorination on PBZZ is able to reduce dielectric constant and increase thermal properties. The co-PBZZ with B-a/F-1 = 1/1 gives low dielectric constant at 2.36 and $\tan\delta$ at 0.0044 which is suitable for insulating applications. Moreover, its thermal properties are also substantially improved over the B-a type PBZZ.

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